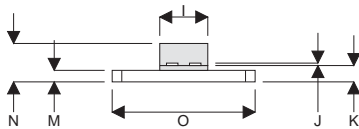
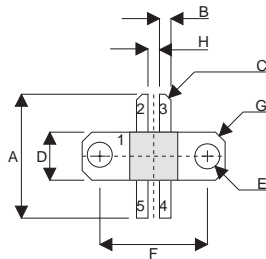


MECHANICAL DATA

**GOLD METALLISED
MULTI-PURPOSE SILICON
DMOS RF FET
5W – 12.5V – 1GHz
PUSH-PULL**



DQ

PIN 1 SOURCE (COMMON) PIN 2 DRAIN 1
 PIN 3 DRAIN 2 PIN 4 GATE 2
 PIN 5 GATE 1

DIM	mm	Tol.	Inches	Tol.
A	16.38	0.26	0.645	0.010
B	1.52	0.13	0.060	0.005
C	45°	5°	45°	5°
D	6.35	0.13	0.250	0.005
E	3.30	0.13	0.130	0.005
F	14.22	0.13	0.560	0.005
G	1.27 x 45°	0.13	0.05 x 45°	0.005
H	1.52	0.13	0.060	0.005
I	6.35	0.13	0.250	0.005
J	0.13	0.02	0.005	0.001
K	2.16	0.13	0.085	0.005
M	1.52	0.13	0.060	0.005
N	5.08	MAX	0.200	MAX
O	18.90	0.13	0.744	0.005

FEATURES

- SIMPLIFIED AMPLIFIER DESIGN
- SUITABLE FOR BROAD BAND APPLICATIONS
- VERY LOW C_{rss}
- SIMPLE BIAS CIRCUITS
- LOW NOISE
- HIGH GAIN – 10 dB MINIMUM

APPLICATIONS

- VHF/UHF COMMUNICATIONS
from 1MHz to 1 GHz

ABSOLUTE MAXIMUM RATINGS ($T_{case} = 25^{\circ}C$ unless otherwise stated)

P_D	Power Dissipation	35W
BV_{DSS}	Drain – Source Breakdown Voltage *	40V
BV_{GSS}	Gate – Source Breakdown Voltage *	$\pm 20V$
$I_{D(sat)}$	Drain Current *	2A
T_{stg}	Storage Temperature	-65 to 150°C
T_j	Maximum Operating Junction Temperature	200°C

* Per Side

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ELECTRICAL CHARACTERISTICS (T_{case} = 25°C unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
PER SIDE					
B _V DSS	Drain–Source Breakdown Voltage	V _{GS} = 0 I _D = 10mA	40		V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 12.5V V _{GS} = 0		1	mA
I _{GSS}	Gate Leakage Current	V _{GS} = 20V V _{DS} = 0		1	µA
V _{GS(th)}	Gate Threshold Voltage*	I _D = 10mA V _{DS} = V _{GS}	1	7	V
g _{fs}	Forward Transconductance*	V _{DS} = 10V I _D = 0.2A	0.18		S
TOTAL DEVICE					
G _{PS}	Common Source Power Gain	P _O = 5W	10		dB
η	Drain Efficiency	V _{DS} = 12.5V I _{DQ} = 0.2A	40		%
V _{SWR}	Load Mismatch Tolerance	f = 1GHz	20:1		—
PER SIDE					
C _{iss}	Input Capacitance	V _{DS} = 12.5V V _{GS} = -5V f = 1MHz		12	pF
C _{oss}	Output Capacitance	V _{DS} = 12.5V V _{GS} = 0 f = 1MHz		10	pF
C _{rss}	Reverse Transfer Capacitance	V _{DS} = 12.5V V _{GS} = 0 f = 1MHz		1	pF

* Pulse Test: Pulse Duration = 300 µs , Duty Cycle ≤ 2%

HAZARDOUS MATERIAL WARNING

The ceramic portion of the device between leads and metal flange is beryllium oxide. Beryllium oxide dust is highly toxic and care must be taken during handling and mounting to avoid damage to this area.

THESE DEVICES MUST NEVER BE THROWN AWAY WITH GENERAL INDUSTRIAL OR DOMESTIC WASTE.

THERMAL DATA

R _{THj-case}	Thermal Resistance Junction – Case	Max. 5.0°C / W
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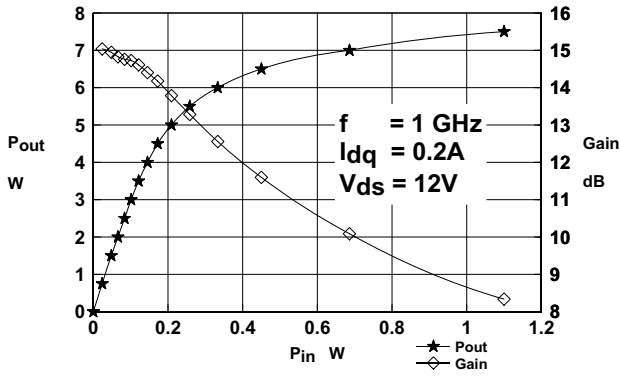


Figure 1 Output Power and Gain vs. Input power

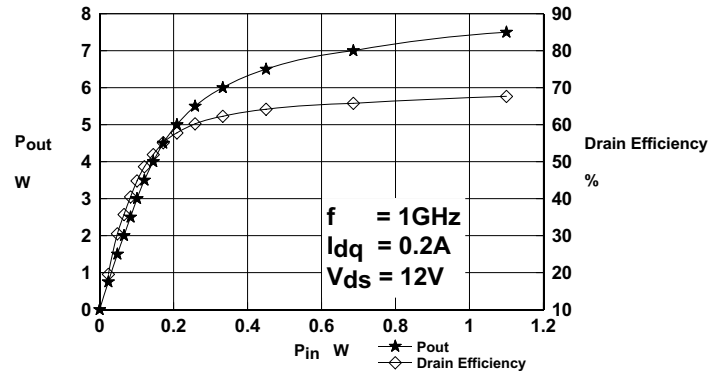


Figure 2 Output Power and Efficiency vs. Input Power

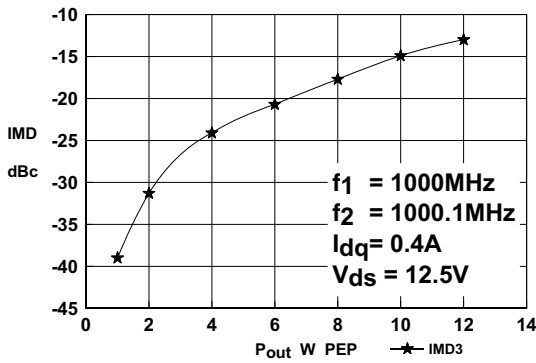


Figure 3 IMD Vs. Output Power.

OPTIMUM SOURCE AND LOAD IMPEDANCE

Frequency MHz	Z _S Ω	Z _L Ω
1000MHz	6.0 + j8.3	7.0 + j9.3

Typical S Parameters

! Vds=12.5V, Idq=0.2A
MHZ S MA R 50

IFreq MHz	S11 mag	ang	S21 mag	ang	S12 mag	ang	S22 mag	ang
100	0.88	-59	13.48	137	0.039	48	0.82	-51
150	0.79	-77	11.02	119	0.047	34	0.75	-65
200	0.74	-88	8.78	105	0.049	24	0.71	-76
250	0.71	-98	7.33	97	0.049	17	0.69	-84
300	0.7	-105	6.36	91	0.048	16	0.68	-91
350	0.69	-111	5.56	81	0.047	9	0.67	-97
400	0.69	-118	4.87	78	0.044	10	0.67	-103
450	0.7	-125	4.3	71	0.04	7	0.67	-110
500	0.71	-131	3.94	68	0.038	10	0.68	-116
550	0.72	-138	3.62	62	0.034	11	0.69	-124
600	0.73	-145	3.43	58	0.033	16	0.7	-130
650	0.75	-151	3.05	51	0.029	21	0.72	-137
700	0.75	-156	2.91	47	0.028	28	0.72	-142
750	0.76	-160	2.59	41	0.027	40	0.72	-147
800	0.76	-162	2.26	36	0.028	49	0.72	-150
850	0.76	-164	2.03	36	0.03	63	0.72	-153
900	0.77	-166	1.93	35	0.034	71	0.72	-156
950	0.77	-168	1.88	34	0.042	79	0.72	-159
1000	0.78	-170	1.81	30	0.05	81	0.72	-162

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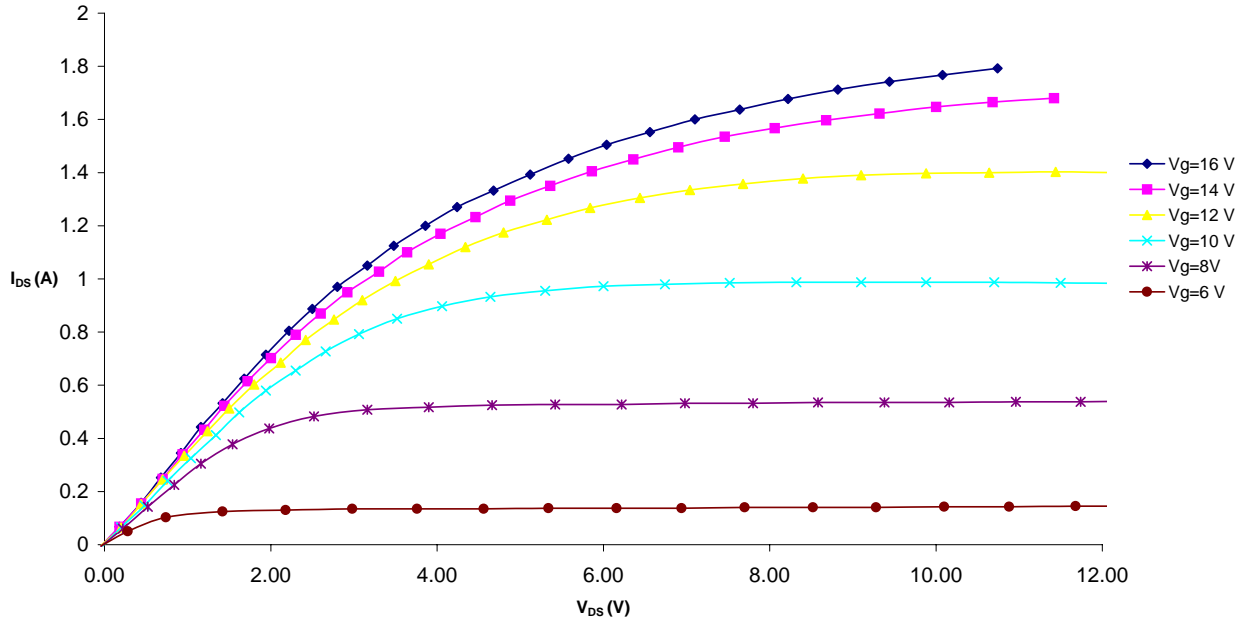


Figure 4 – Typical IV Characteristics.

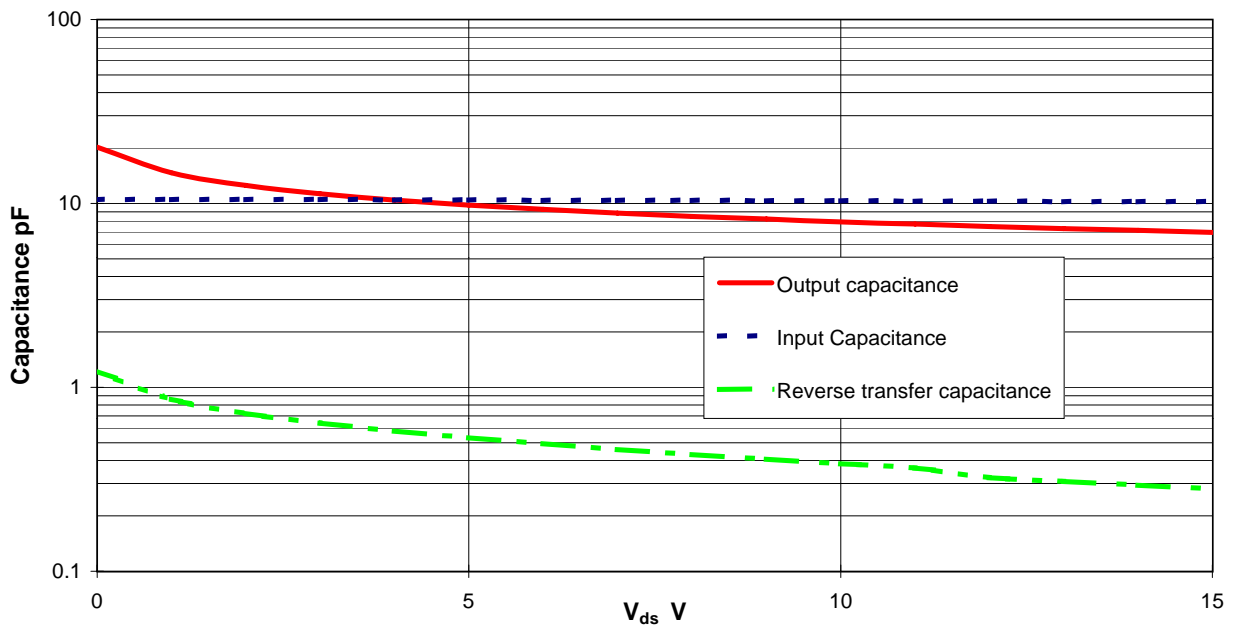
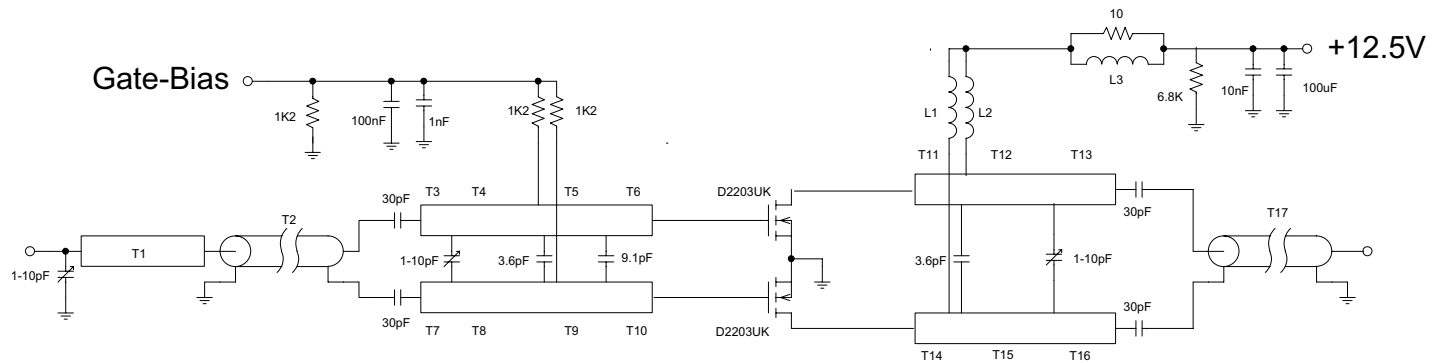


Figure 5 – Typical CV Characteristics.

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D2203UK 1000MHz TEST FIXTURE

Substrate 0.8mm thick PTFE/glass

All microstrip lines $W=2.7\text{mm}$

- T1 15.7mm
- T2, T17 45mm 50 Ohm UT34 semi-rigid coax
- T3, T7 7mm
- T4, T8 15mm
- T5, T9 7.6mm
- T6, T10 8mm
- T11, T14 8mm
- T12, T15 11.2mm
- T13, T16 7mm

L1, L2 6 turns of 24swg enamelled copper wire, 3mm i.d.

L3 1.5 turn 24swg enamelled copper wire on Siemens B62152-A7X 2 hole core